

# System Dynamics Identification by means of Adjustable Models

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Two methods for system dynamics identification based on processing of recorded stochastic input and output signals of a system by means of adjustable models were thoroughly experimentally tested on a laboratory scale.

The theoretical discussion of the methods involved and results obtained yields insight into the advantageous properties and intrinsic limitations of straightforward model methods.

## 1. INTRODUCTION

Among other methods for identifying dynamic parameters of control systems, the methods based on knowledge of input and output signals of general stochastic character seem to raise a rising interest in the last time. Blandhol [1] and Norkin [2] showed in their papers some new possibilities of the model method.

The authors of the reported work decided to investigate experimentally on a laboratory scale some of the possible modifications of the model methods using the specialized computer MUSA 6 [3, 4, 5] which is able to record and reproduce very exactly comparatively long intervals of input and output signals of some system.

The main interest was in parameter identification of systems which, for technological or economical reasons, permit an analysis based on stochastic signals recorded during normal operation only.

The basic methodology of the experiment was therefore chosen similar to that described in [1]:

First, the signal from a generator of stochastic processes  $G$  (fig. 1) was connected to the input of a system  $S$ . The transfer function of this system was supposed to be of the form

$$(1) \quad F_s(p) = \frac{\beta_0 + \beta_1 p + \dots + \beta_n p^n}{\alpha_0 + \alpha_1 p + \dots + \alpha_n p^n} = \frac{M_\sigma(p)}{N_\sigma(p)}$$

where  $M_o(p)$  and  $N_o(p)$  denote the polynomials of the nominator and denominator, respectively.

The input signal  $x_1$  and the output signal  $x_2$  were recorded in the memory MM. When analysed, the signals  $x_1$  and  $x_2$  were reproduced and fed into a model M formed on an analog computer (fig. 2).

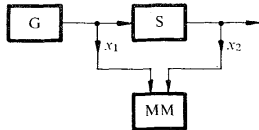


Fig. 1. Recording of signals.

On the model coefficients  $a_i$  and  $b_i$  were set by hand so as to minimize the mean square value  $K$  of the deviation  $\Delta$ :

$$(2) \quad K = \frac{1}{T} \int_0^T \Delta^2(t) dt$$

which was used as the criterion for the quality of approximation of the values  $\alpha_i$  and  $\beta_i$  (now supposed to be unknown) by the values  $a_i$  and  $b_i$ , respectively.

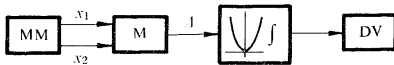


Fig. 2. Analysis of recorded signals.

For each setting of  $a_i$  and  $b_i$  the whole recorded data for  $x_1$  and  $x_2$  were reproduced at least once; according to the obtained value of the criterion  $K$ , indicated on a digital voltmeter DV, a new setting of  $a_i$  and  $b_i$  was chosen.

2. METHODS USED FOR FORMING THE DEVIATION SIGNAL  $\Delta$

One of the most straightforward methods for this purpose is illustrated in fig. 3. On the model the transfer function

$$(3) \quad F_s(p) = \frac{b_0 + b_1 p + \dots + b_n p^n}{a_0 + a_1 p + \dots + a_n p^n} = \frac{M_s(p)}{N_s(p)}$$

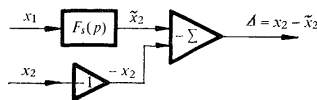


Fig. 3. Basic scheme of the ITF method.

510 is formed. The Laplace transform of the deviation signal is then

$$(4) \quad \Delta(p) = X_1(p)[F_o(p) - F_s(p)].$$

In [2] a new identification method is suggested and theoretically motivated. The structure in fig. 4 is based on the general principles used in this method for forming

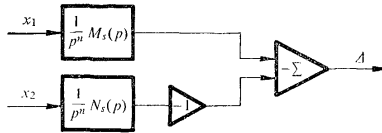


Fig. 4. Basic scheme of the DTF method.

the deviation signal  $\Delta$ . Here

$$(5) \quad \begin{aligned} \Delta(p) &= X_2(p) \frac{1}{p^n} N_s(p) - X_1(p) \frac{1}{p^n} M_s(p) = \\ &= X_1(p) \frac{1}{p^n} [N_s(p) F_o(p) - M_s(p)], \end{aligned}$$

$$(6) \quad \Delta(p) = X_1(p) [F_o(p) - F_s(p)] \frac{N_s(p)}{p^n}.$$

The transfer functions  $N_s(p)/p^n$  and  $M_s(p)/p^n$  consist of pure integrations. This would in practice inevitably lead to instability caused by DC unbalance, and drifts and a steady increase of  $\Delta$  limited only by amplifier saturation would be the result. In [2] this difficulty is overcome by postulating values of integration constants in each of a number of successive integration steps which ensure the mean value of the involved functions to be the same after integration as before.

This postulate was not respected quite exactly, because otherwise a rather complex scheme would be necessary. But a fairly good approximation was used. This was achieved by a change in the transfer functions  $N_s(p)/p^n$  and  $M_s(p)/p^n$  ensuring insensitivity of the method to the values of integration constants by suppression of the lowest part of the frequency band used. As a rule this part is, of almost no interest for identification purposes.

We can, therefore, use a high-pass filter with a transfer function  $F_H(p)$  and choose a sufficiently low limiting frequency so that the interesting part of the  $\Delta$  spectrum is left unchanged.

Then, instead of the transfer functions  $N_s(p)/p^n$  and  $M_s(p)/p^n$  the transfer functions

$$(7) \quad \frac{N_s(p)}{p^n} F_H(p) \quad \text{and} \quad \frac{M_s(p)}{p^n} F_H(p)$$

are used, where the high-pass filter transfer function

$$(8) \quad F_H(p) = \frac{p^m}{p^m + \sum_{i=1}^m c_i p^{m-i}}$$

is formed so as to secure minimum deviation from 1 above the chosen limiting frequency.

Both transfer functions in (7) are then realizable by conventional analog computer techniques without difficulties, because the zero poles in (7) are cancelled by zeroes of (8); the denominator of  $F_H(p)$  must, of course, be stable.

Then, there results the deviation signal  $\Delta$ :

$$(9) \quad \Delta(p) = X_1(p)[F_o(p) - F_s(p)] \frac{N_s(p)}{p^n} F_H(p).$$

This method in accordance with fig. 4 will be referred to as the Distributed Transfer Function Method (DTF), whereas the first one will be referred to as the Integrated Transfer Function Method (ITF) for distinction.

The DTF method has some advantageous features which cannot be found in the ITF method. The most important one is the mutual orthogonality of settings of coefficients  $a_i$  with even and odd potences of  $p$  in the  $N_s(p)$  transfer function. By this orthogonality, proved in [2], the independence of the value  $a_i$  defined by

$$(10) \quad \frac{\partial K}{\partial a_i} = 0$$

on the settings of all values  $a_{i+2k+1}$  ( $k$  is an integer) is understood. A similar independence of the values  $b_i$  defined by

$$(11) \quad \frac{\partial K}{\partial b_i} = 0$$

on the settings of all values  $b_{i+2k+1}$  can be found both in the DTF and the ITF methods.

Comparison of the expressions (6) and (9) for  $\Delta(p)$  in both methods shows that the signal  $\Delta$  for DTF can be gained from the signal  $\Delta$  in ITF by adding a filter with the transfer function

$$\frac{N_s(p)}{p^n} F_H(p).$$

The transfer function  $N_s(p)/p^n$  depends on  $a_i$  settings. It is this dependence which is responsible for the orthogonality of settings of coefficients  $a_i$  with odd and even indexes.

The absolute value of  $N_s(p)/p^n$  is, however, always greater on the lower end of the used spectral band than on the upper end. The addition of the transfer function  $N_s(p)/p^n$  results therefore in a relative suppression of higher frequencies. This can hardly be considered an advantage, because it makes more difficult to recognize details of the system transfer function in the higher frequency region which, as a rule, is the most important region for control purposes.

One of the main tasks of the experiment which was carried out in November 1965 in the Institute of Information Theory and Automation of the Czechoslovak Academy of Sciences, in collaboration with Mr. V. D. Spiridonov from the Institute of Automation and Telemechanics of the Academy of Sciences of the USSR, according to an agreement between the mentioned Institutes, was the verification and the comparison of the features of both methods.

### 3. METHODOLOGY OF THE EXPERIMENT

For simulation of the system and for creating adjustable models, a small analog computer MEDA (described in [6]) was used. There was no substantial departure from conventional

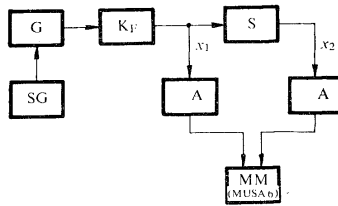


Fig. 5. Recording apparatus (A — amplifier).

feedback analog computer programming techniques and it seems therefore unnecessary to show the used schemes in detail.

The block diagram for recording the signals  $x_1$  and  $x_2$  into the memory is shown in fig 5. The input random signal  $x_1$  was obtained by filtering of a telegraph random signal by the filter  $K_F$ . The telegraph random signal was delivered by the generator G of the random process GENAP, described in [17] which was controlled by a signal generator SG. The shape of the autocorrelation function of this signal is shown in fig. 6 where  $\theta$  is equal to the basic interval of the telegraph signal. For the described measurements  $\theta = 0.5$  ms was chosen.

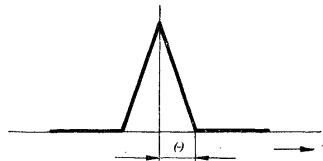


Fig. 6. Autocorrelation function of random signal generator output.

The signal  $x_1$  should have a spectral density similar to spectral densities expected to be found in  $x_1$  signals in field applications. These will be generally falling with increasing frequency.

Therefore, an integrating network was chosen for the filter  $K_F$  with the transfer function  $1/(1 + \tau_F p)$ . Its time constant  $\tau_F$  was made equal to the highest time constant of the system S.

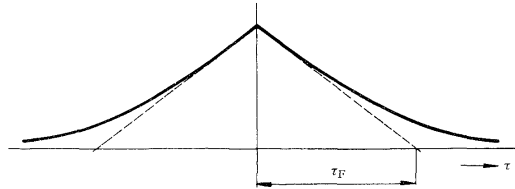


Fig. 7. Autocorrelation function of  $x_1(t)$ .

With the examined system transfer functions its numerical value was

$$\tau_F = 100 \text{ ms.}$$

Because  $\tau_F \gg \Theta$ , the autocorrelation function of the input noise  $x_1$  has a nearly exponential form (see fig. 7) with the time constant  $\tau_F$ .

A desirable frequency response  $|F_H(j\omega)|$  of general form is shown in fig. 8. A high-pass filter

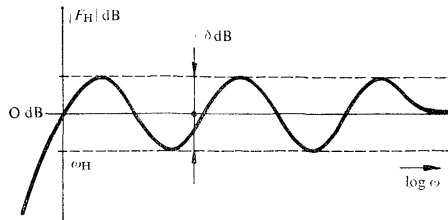


Fig. 8. Filter frequency response  $F_H$ , generally.

of the second order with the amplitude frequency response shown in fig. 9 and the transfer function

$$(13) \quad F_H(p) = \frac{p_2}{p_2 + 6,132p + 27,47}$$

was used in the experiment.

To the basic schemes shown in fig. 2, 3 and 4 several further elements were added, as indicated in fig. 10.

Differentiating networks with time constants  $\tau_1$  and  $\tau_2$  were used to remove direct current components arising by high amplification of drift and zero unbalance of D.C. amplifiers. Since

514 differentiating networks are high-pass filters, the same conclusions are valid for their use as for the high-pass filter  $F_H(p)$ .

The MUSA 6, used as a magnetic tape memory, repeats periodically the recorded signals  $x_1$  and  $x_2$  during the identification process. Every time a play back of the signals is started or finished, transient processes in the used models and filters are generated. These transients are caused by abrupt changes in the recorded  $x_1$  and  $x_2$  signals on the beginning and end of their recording.

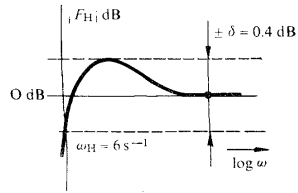


Fig. 9. Frequency response  $F_H$  of filter, as used.

The influence of these transients is suppressed by the key  $k$ . This key closes only after a time, necessary for full decay of transients, has elapsed from the beginning of  $x_1$  and  $x_2$  recordings; it opens just before their end. Then the signal  $\Delta$  obtained does not differ from the signal  $\Delta$  which would be obtained with infinitely long records.

The useful part of  $x_1$  and  $x_2$  processes, that is, the part not suppressed by  $k$ , was represented by some 35 000 values of each of the variables.

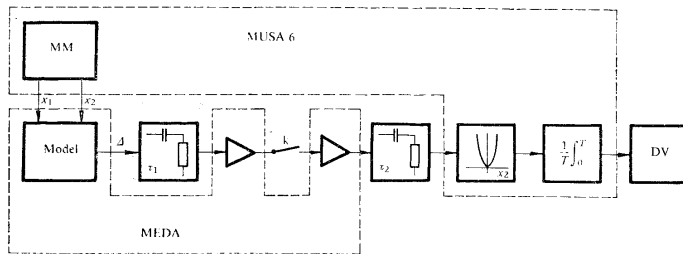


Fig. 10. Basic scheme used for identification ( $\tau_1 = 165$  msec used for ITF and  $\tau_1 = \infty$  for DTF;  $\tau_2 = 1.6$  sec).

#### 4. HYPERSURFACE FORMS

The criterion  $K$ , established and measured in accordance with (2) and the methods described, is a function of the settings of the coefficients  $a_i$  and  $b_i$ , and it depends also on the signal and gain levels used.

To exclude this last mentioned dependence, and to get results of a more general

meaning, a dimensionless measure of  $K$  was introduced:

$$(14) \quad \varkappa = \frac{K}{K_T}$$

where

$$(15) \quad K_T = \frac{1}{T} \int_0^T A_T^2 dt.$$

Here  $A_T$  denotes the deviation signal  $A$  for the correct setting of  $a_i$  and  $b_i$ , but with the  $x_1$  or  $x_2$  path in fig. 10 disconnected. The form of the hypersurfaces defined by

$$(16) \quad \varkappa = f(a_i, b_i) = \text{const}$$

is of great interest from the identification standpoint.

The function

$$(17) \quad \varkappa = f(a_i, b_i)$$

can be in the neighbourhood of the optimum approximated by a quadratic form; as will be shown by the experimental results, this approximation is fairly good for surprisingly great deviations of  $a_i$  and  $b_i$  from their optimal values.

Denoting the relative deviations of  $a_i$  and  $b_i$  from their optimal values  $a_{i0}$  and  $b_{i0}$  by

$$(18) \quad \delta_i = \frac{a_i - a_{i0}}{a_{i0}}, \quad 0 \leq i \leq n,$$

$$(19) \quad \delta_{n+i} = \frac{b_i - b_{i0}}{b_{i0}}, \quad 0 < i \leq n$$

( $b_0$  is supposed to be chosen as the constant coefficient) one can write the approximation of (17) as follows:

$$(20) \quad \varkappa = \sum_{i,k=0}^{i,k=2n} \lambda_{ik} \delta_i \delta_k,$$

The measurement was carried out especially for two cases:

a) only one  $\delta_i$  is set to a chosen value, all other  $\delta_k$ , where  $k \neq i$ , being left zero: For this case (20) yields:

$$(21) \quad \varkappa = \lambda_{ii} \delta_i^2;$$

b) one  $\delta_i$  is set to a chosen value, alle other  $\delta_k$ , where  $k \neq i$ , being adjusted to minimize  $\varkappa$ :

$$(22) \quad \frac{\partial \varkappa}{\partial \delta_k} = 0 \quad \text{for } k \neq i.$$



516 Then (21) yields

$$(23) \quad \varkappa = \mu_i \delta_i^2$$

where

$$(24) \quad \mu_i = \frac{M}{M_{ii}}$$

In (24)  $M$  denotes the determinant of the matrix  $\|\lambda_{ik}\|$  and  $M_{ii}$  is the subdeterminant for the element  $\lambda_{ii}$ . The changes in  $\delta_k$  are related to the change in  $\delta_i$  by

$$(25) \quad \delta_k = \frac{M_{ik}}{M_{ii}} \delta_i = \mu_{ik} \delta_i.$$

The values

$$(26) \quad \alpha_{ik} = \frac{M_{ik}}{M} = \frac{\mu_{ik}}{\mu_i}, \quad \alpha_{ii} = \frac{M_{ii}}{M} = \frac{1}{\mu_i}$$

which can be evaluated from the measured values of  $\varkappa_i \delta_i$  and  $\delta_k$  according to (23), (24) and (25), form a symmetrical matrix. The matrices  $\|\lambda_{ik}\|$  and  $\|\alpha_{ik}\|$  are related by the equation

$$(27) \quad \|\alpha_{ik}\| \cdot \|\lambda_{ik}\| = 1$$

and hence values of  $\|\lambda_{ik}\|$  can be computed from measured values  $\|\alpha_{ik}\|$ , or vice versa.

The axes of the hyperellipsoid corresponding to (20) are determined by the eigenvalues  $\lambda$  of the matrix  $\|\lambda_{ik}\|$ . For a given  $\varkappa$  the length of an axis is equal to  $\sqrt{(\varkappa/\lambda)}$  and its direction is given by the respective eigenvector.

## 5. NOISE INFLUENCE

Let us consider a field application of the mentioned model methods where the studied system is noisy. This situation is illustrated in fig. 11. Besides the input signal  $x_1$

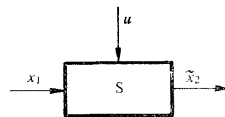


Fig. 11. Noise influence on  $x_2$ .

also a noise  $u$  enters the system, causing the output to consist of two components:

$$(28) \quad \tilde{x}_2 = x_2 + v$$

where  $x_2$  is due to the input  $x_1$  and related to it by the transfer function  $F_v(p)$  and  $v$  is due to the noise  $u$ . Both the noise and the transfer function relating  $v$  to  $u$  are supposed to be unknown.

For the ITF method the signal  $A$  influenced by noise will be

$$(29) \quad \tilde{A} = A + v.$$

Let us suppose that  $u$  and  $x_1$  are statistically independent. Then for the criterion we get:

$$(30) \quad \bar{K} = \frac{1}{T} \int_0^T \tilde{A}^2 dt \doteq \frac{1}{T} \int_0^T (A^2 + v^2) dt$$

because due to statistical independence of  $x_1$  and  $u$  also  $v$  and  $x_1$ ,  $v$  and  $x_2$ , and hence,  $v$  and  $A$  are statistically independent. The mean value of the  $A \cdot v$  product tends, therefore, to zero if  $T$  is increased sufficiently

$$(31) \quad \lim_{T \rightarrow \infty} \frac{1}{T} \int_0^T A \cdot v dt = 0.$$

Thus,

$$(32) \quad \bar{K} = K + \bar{K}_{\min}$$

where  $\bar{K}_{\min}$  is the value of  $\bar{K}$  for optimum setting of  $a_i$  and  $b_i$ , that is for  $A = 0$ :

$$(33) \quad \bar{K}_{\min} = \frac{1}{T} \int_0^T v^2 dt.$$

It can be seen from (32) that a minimum of  $\bar{K}$  occurs, if  $K$  is minimal (zero), because  $\bar{K}_{\min}$  is a constant. No change in the minimum position will be caused by the disturbing noise  $u$ , and the same  $a_i$  and  $b_i$  values should result.

But this is not exactly the case, because the values of  $K$  gained from the scheme on fig. 10 are never quite accurate. They are influenced by errors, due partly to the simplifications used (finiteness of recording intervals, supposition of system linearity) and partly to apparatus imperfectness (e.g. drifts, model nonlinearity, gain variations, external noises).

As a result of these errors the correct value of  $\bar{K}$  can be measured only with some uncertainty the relative value of which in neighbourhood of the minimum of  $\bar{K}$  is designated by  $\vartheta$ .

The minimal significant change in  $\bar{K}$  will then be equal to the absolute value of this uncertainty:

$$(34) \quad (\Delta \bar{K})_{\min} = K = \vartheta \bar{K}_{\min}.$$

518 Such change in  $\tilde{K}$  has to be produced by the minimal discernible deviation from optimum in settings of the coefficients  $a_i$  and  $b_i$ . For the ITF method

$$(35) \quad \Delta_T = x_2$$

so that (15) yields

$$(36) \quad K_T = \frac{1}{T} \int_0^T x_2^2 dt.$$

The RMS signal to noise ration  $\eta$  in the  $\tilde{x}_2$  signal is then given by

$$(37) \quad \eta^2 = \frac{K_T}{\tilde{K}_{\min}}$$

and for the minimal significant change in  $\tilde{K}$  from (34) one gets an expression for the minimal significant change in  $\varkappa$ :

$$(38) \quad \varkappa = \frac{\vartheta}{\eta^2}.$$

Combining (38) and (23) one gets

$$\delta_i = \frac{1}{\eta} \sqrt{\frac{\vartheta}{\mu_i}}$$

which determines the maximal relative error in  $a_i$  setting to be expected in the presence of a disturbing noise. In a similar way, the length of the longest axis of the hyperellipsoid for the  $\varkappa$  value defined by (38):

$$(40) \quad \delta_T = \frac{1}{\eta} \sqrt{\frac{\vartheta}{\lambda_{\min}}}$$

is the length of the maximum error vector

$$(41) \quad \delta_T = \sqrt{(\sum_i \delta_i^2)}.$$

Thus, the sensitivity coefficients  $\lambda_{ik}$  and  $\mu_i$  and the eigenvalues  $\lambda$  are very important figures of merit, showing directly the limits imposed on the examined methods by noise and apparatus imperfectness. The values  $\mu_{ik}$  allow to estimate the mutual interference of individual coefficient setting in the optimization process; for an ideal orthogonality all  $\mu_{ik}$ ,  $i \neq k$ , would be zero.

The analysis for the DFT method has to take into account the additive filtering action on the deviation signal defined by (12). Signals  $\tilde{x}_2$  and  $\tilde{v}$ , gained from  $x_2$  and  $v$  by filtering through a filter (12), have to be substituted for  $x_2$  and  $v$  in (29), (30), (31) and (33).

The value  $\tilde{K}_{\min}$  then depends on  $a_i$  settings, because the transfer function (12) and hence  $\bar{v}$  are dependent on these settings.

Consequently, the position of the minimum of  $\tilde{K}$  differs from the position of the minimum of  $K$  generally, the change in individual coefficients being a complex function of the signal to noise ratio,  $x_2$  and  $b$  spectral density forms and  $\alpha_i$  and  $\beta_i$  values. The exact analysis of this function exceeds the scope of this paper.

But it may be noted that the analysis of noise influence derived for the ITF method applies also to the DTF method in the special case where only noise generated in the computing machinery, independent on  $a_i$  and  $b_i$  settings, can be considered as responsible for the  $\tilde{K}_{\min}$  value.

## 6. THE RESULTS

Systems with four transfer functions were simulated and then both DTF and ITF identification methods were applied to the recorded signals. The used transfer functions were as follows:

a) A simple first order transfer function

$$(42) \quad F_a(p) = \frac{1}{1 + 0,1p}$$

b) A simple second order transfer function without numerator and with real roots:

$$(43) \quad F_a(p) = \frac{1}{1 + (4/30)p + (1/300)p^2} = \frac{300}{(p + 10)(p + 30)}$$

c) A simple second order transfer function without numerator and with complex roots:

$$(44) \quad F_a(p) = \frac{1}{1 + (p/10)\sqrt{(2) + (p^2/100)}} = \frac{100}{[p + 5\sqrt{(2)(1+j)}][p + 5\sqrt{(2)(1-j)}]}$$

d) A second order transfer function with a first order numerator and real roots:

$$(45) \quad F_a(p) = \frac{1 + p/20}{1 + (4/30)p + (p^2/300)} = \frac{15(p + 20)}{(p + 10)(p + 30)}$$

For a), b), c) a detailed measurement, consisting of several hundred points, of the  $\kappa$  function (17) was taken allowing to construct the hypersurfaces  $\kappa = \text{const}$ . For the simplest case a) the system of these hypersurfaces is reduced to a system of contour lines  $\kappa = \text{const}$ . in the  $\delta_0 - \delta_1$  plane. For b) and c) the equation  $\kappa = \text{const}$ . describes conventional three-dimensional surfaces. An idea about the overall form of these surfaces can be drawn from the three normal cross-sections formed by contour lines in the three normal planes, defined by the  $\delta_0$  and  $\delta_1$ ,  $\delta_1$  and  $\delta_2$ ,  $\delta_2$  and  $\delta_0$  pairs of axes. These sections are shown in figs 12 to 15.

From figs 12 to 15 it is quite apparent that the approximation of the  $\kappa$  function (17) by the quadratic form (20) is fairly good for  $\delta_i$  to some 10%–20% and for  $\kappa$  to  $64 \cdot 10^{-4}$ . This can be seen from the very nearly elliptic form of the contour lines and from the very nearly linear scales formed on any line passing through the origin by interceptions with the system of contour lines corresponding to a quadratic scale of  $\kappa$  values.

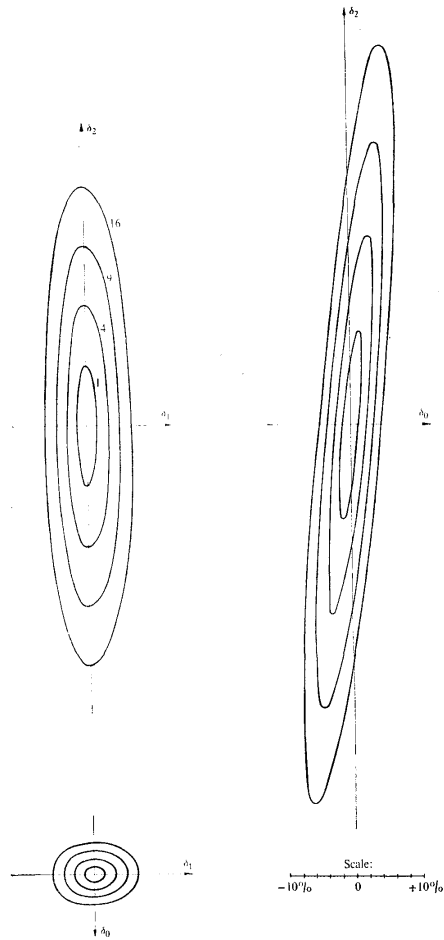


Fig. 12. Contour lines gained by three normal sections through the system of surfaces  $\kappa = \text{const.} = (1, 4, 9, 16) \cdot 10^{-4}$  for the second order transfer function with real roots and DTF method.

The measurements taken showed that also for  $\delta_i$  twice (and  $\kappa$  four times) as great as shown in figs 12 to 15 the departure from the quadratic form is not very significant.

No secondary minima were found in any of the reported cases; thus it can be concluded that the hypersurfaces in both identification methods seem to have a fairly simple, nearly quadratic form in a wide neighbourhood of the optimal settings of  $a_i$  and  $b_i$  coefficients.

This would be no doubt very advantageous for automation of the identification procedure. The only, but very significant remaining trouble arises from the possibility of very lengthy elliptic

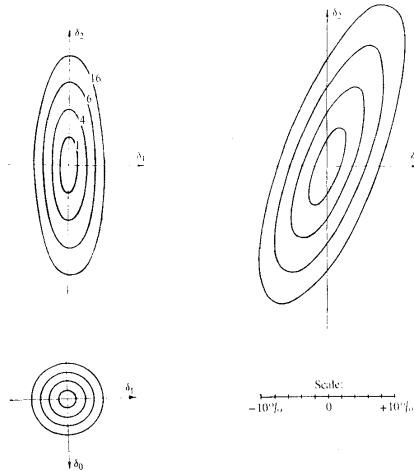


Fig. 13. Same as fig. 12, but ITF method.

(or generally hyperellipsoidal) forms with considerable inclination to coordinate system axes. As illustrated by fig. 16 in such a case finite probe steps in all four directions from point  $P$  can lead to a false conclusion that  $P$  is a minimum. Therefore taking account of this possibility, some more elaborate optimizing method has to be used.

In some of the figures, especially figs. 14 and 15, there is a slight, but noticeable departure from the orthogonality of odd and even coefficients. The reason for this discrepancy with the orthogonality theory could lie, theoretically, in a short length of the recorded processes. But with the number of samples used a substantial deviation from the asymptotic values has a low probability. Another explanation seems more likely, that is, model imperfectness. With the used frequency band ranging to 2 kHz the small machine MEDA worked well on the top of its possibilities with respect to frequency response. Additional phase shifts and parasitic capacitive couplings may cause several other coefficients of the transfer function to be slightly influenced by the change of the element value (e.g. potentiometer setting) corresponding to any given coefficient. In a first approximation the effect of this is a linear transformation of coordinate axes comprising shifts and rotations.

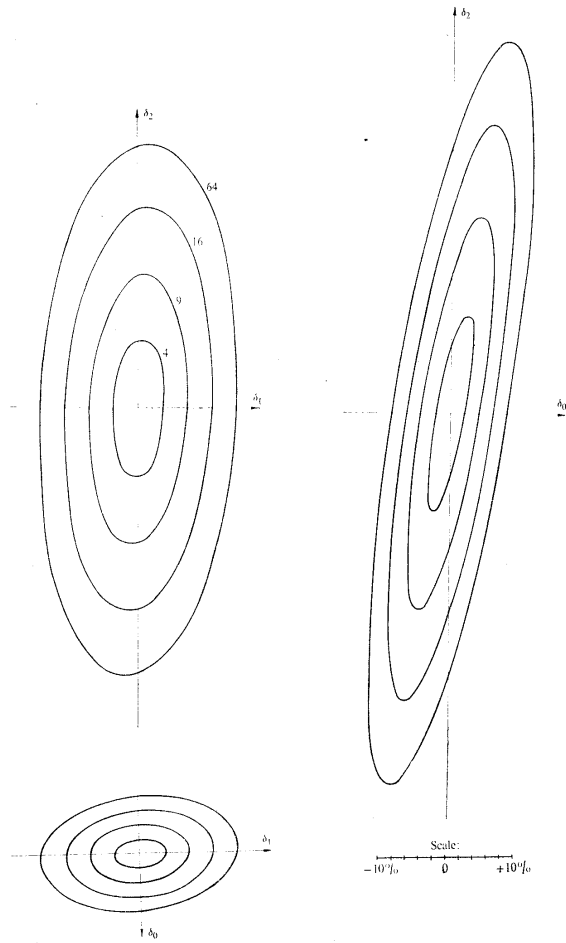


Fig. 14. Contour lines gained by three normal sections through the system of surfaces  $\kappa = \text{const.} = (4, 16, 36, 64) \cdot 10^{-4}$  for the second order transfer function with complex roots and DTF method.

Respecting this observation, and noticing that there is no noticeable change in the inclination of ellipses when  $\kappa$  is increased, one may conclude that no substantial difference, concerning orthogonality of odd and even coefficients, can be observed in the DTF and ITF method, though theory guarantees this orthogonality for the DTF method generally and for the ITF method only for the optimal setting.

For the last case d), the detailed measurement which should consist of at least six normal sections was not made. Nevertheless, sufficient points were taken to confirm the applicability of the quadratic approximation (20).

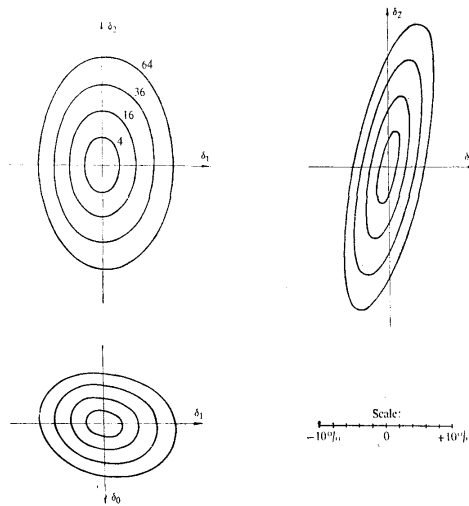


Fig. 15. Same as fig. 14, but ITF method.

The quantitative discussion can be more readily made from the  $\|\alpha_{ik}\|$  and  $\|\lambda_{ik}\|$  matrix values and axis lengths and positions. These are shown in tables 1, 2 and 3. The vectors of axes shown in these tables are shown for  $\kappa = 1$ , and their absolute value is thus given by the respective eigenvalue:

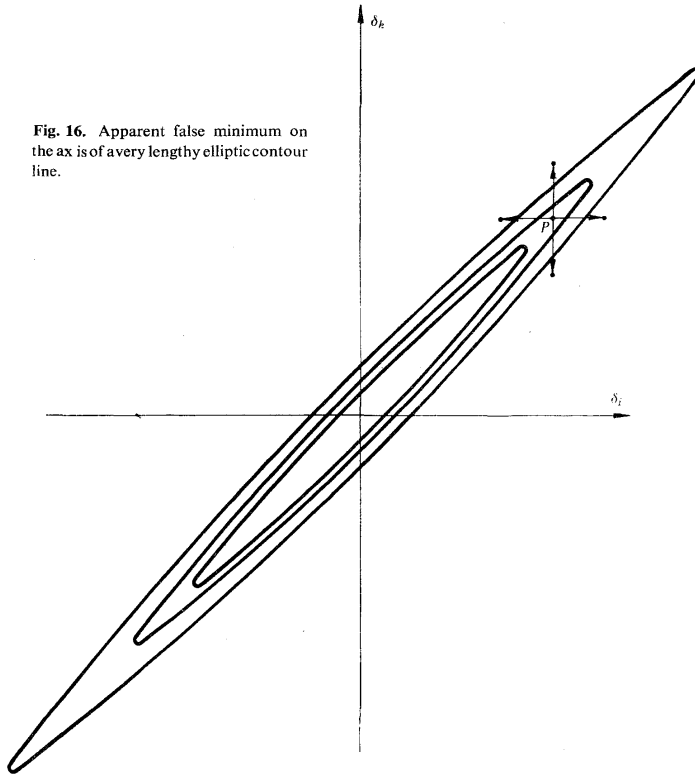
$$(46) \quad \delta_{\text{abs}} = \sqrt{\frac{1}{\lambda}}.$$

Equation (37) may then be rewritten as:

$$(47) \quad \delta_T = \frac{\delta_{\text{absmax}}}{\eta} \sqrt{\vartheta}.$$



Fig. 16. Apparent false minimum on the axis of a very lengthy elliptic contour line.



Taking  $\beta = 0.01$  and  $\eta = 10$  as arbitrary values, representing a rough estimate of very favourable conditions in field application of the methods described, one gets

$$(48) \quad \delta_{\gamma} = 0.01 \delta_{\text{absmax}} = \delta_{\text{absmax}}^{\circ\prime\prime}$$

and the column  $\delta_{\text{abs}}$  in tables 1, 2, 3 can be regarded as total identification error expressed in percents and expected with signal to noise ratio 10 and method and apparatus inaccuracy of finding  $\tilde{K} \mathcal{G} = 1\%$ .

From this standpoint the results for the first order transfer function shown in table 1 can be regarded as encouraging both for the small absolute value of  $\delta_{\text{abs}}$  and for orthogonality of  $\delta_0$  and  $\delta_1$ .

Table 1.

Matrices for First Order Transfer Function

Method	$\ \alpha_{ik}\ $		$\ \lambda_{ik}\ $		$ \lambda_{ik} $	Vectors of axes		
	$\delta_0$	$\delta_1$	$\delta_{abs}$					
DTF	1.21	0	0.826	0	0.464	0	1.4	1.4
	0	1.96	0	0.511		1.1	0	1.1
ITF	1.56	0	0.64	0	0.2415	0	1.62	1.62
	0	2.64	0	0.379		1.25	0	1.25

Unfortunately, the picture changes substantially if the order of the transfer function is raised by a single unit. The longest axis grows very rapidly, in one case as much as ten times. Also the ratio of longest to shortest axis increases approximately in the same proportions.

The ITF method is here substantially better than the DTF method, giving approximately a 2.5 times shorter longest axis and a 2 or 3 times smaller ratio of longest to shortest axes. Also the inclination of the longest axis is less with the ITF method.

A quite similar difference exists between the results for real and complex roots for any of the methods.

The explanation can be easily found by spectral density considerations. The used noise, due to its autocorrelation function form, has a spectral density function falling 100 times for a decade of frequency change over  $\omega = 10$ . Moreover, the system itself damps the higher frequencies substantially. For the DTF method, when compared with the ITF method, a further damping of high frequencies, expressed by the additive filter (12), takes place.

It is obvious that such changes in the transfer function of the model which affect the high frequency part of the respective frequency response only will under the described circumstances affect only a small part of the total noise energy, that is, their impact on  $\kappa$  will be hardly noticeable.

Therefore, the transfer function with real roots having one root substantially farther in the high frequency region, and the DTF method having more damping of high frequency components, yield poorer results in this case.

Unfortunately, the high frequency part of a frequency response characteristic is, as a rule the most interesting part for control applications. The input noise spectrum, the falling character of which is one of the sources of troubles, will hardly have a better composition in field applications.

The matrices in table 2 were computed from  $\lambda_{ik}$  values computed from axes positions of the ellipses in figs. 12 to 15. The matrix  $\|\lambda_{ik}\|$  was then inverted and checked with the  $\|\alpha_{ik}\|$  values gained from measured  $\mu_i$  and  $\mu_{ik}$  values. There were no troubles with the sensitivity of the inversion process to experimental inaccuracies of  $\lambda_{ik}$  values and a good agreement was reached.

Of course, some of the  $\|\lambda_{ik}\|$  and  $\|\alpha_{ik}\|$  matrices have nonzero values  $\lambda_{01}$ ,  $\lambda_{12}$ ,  $\alpha_{01}$ ,  $\alpha_{12}$ , which correspond to the discrepancy with the orthogonality theory mentioned in the discussion of fig. 12 to 15.

The situation with the matrices  $\|\alpha_{ik}\|$  in table 3 was worse. Their rows are nearly linearly dependent, indicating a needle form of the hyperellipsoid. The exact values of both  $\|\lambda_{ik}\|$  and  $\|\alpha_{ik}\|$  matrices could be determined only by a method using the knowledge of diagonal values of both matrices, which are least influenced by measuring errors, and some of the most dependable values of  $\|\alpha_{ik}\|$ , that is, of the values of which the inaccuracy has least influence on the computed values.  $\alpha_{02}$  and  $\alpha_{03}$  have proved to have this quality. But possible inaccuracies involved by this method have no effect on the  $\delta_{abs}^2$  max value which is here practically equal to the

Table 2. Matrices for Second Order Transfer Function,  $b_1 = 0$

System and method	$\ x_{ik}\ $			$\ \lambda_{ik}\ $			$1000 \times \ \lambda_{ik}\ $			Vectors of axes			
	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_{abs}$
Real roots, DTF	3.1	0	18	0.73	0	-0.071	1.55	0	13.6	1.4	0	13.6	13.7
	0	2.5	0	0	0.39	0	1.55	0	1.59	1.4	0	1.59	1.59
Real roots, ITF	18	0	186	-0.071	0	0.012	9.88	0	-0.119	1.16	0	-0.119	1.16
	3.2	-0.06	6.2	0.53	0	-0.11	9.88	0	5.4	1.22	-0.056	5.4	5.53
Complex roots, DTF	6.2	-0.28	29	-0.11	0.0054	0.058	5.345	0.051	perpendicular plane to longest axes	1.09	0.116	6.9	6.98
	2.3	-0.08	7.3	0.86	0.051	-0.13	5.345	0.3	0.0044	1.09	-1.83	0.0044	1.84
Complex roots, ITF	-0.08	3.4	0.77	0.051	0.3	-0.0127	82.84	-0.13	0.095	1.05	0.095	-0.167	1.07
	7.3	0.77	48	-0.13	-0.0127	0.042	82.84	1.07	0.254	1.07	0.254	2.77	2.98
Complex roots, ITF	1.88	0.33	2.7	-0.095	0.61	0.0088	1.09	-0.095	1.27	1.07	1.27	-0.167	1.19
	0.33	1.7	0.53	-0.36	-0.0088	0.255	1.09	-0.36	0.313	-0.84	0.126	0.313	0.90

Table 3. Matrices for Second Order Transfer Function,  $b_1 \neq 0$

Method	$\ x_{ik}\ $			$\ \lambda_{ik}\ $			$10^6 \ \lambda_{ik}\ $			Vectors of axes			
	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_0$	$\delta_1$	$\delta_2$	$\delta_3$
DTF	1.5	0.15	7.6	0.38	0.96	0	0.2413	0.034	128	106	1.1	1.1	1.1
	0.15	1800	5400	4500	0	0.3	0.2413	-0.7	2.04	-4.61	4.75	6.96	6.96
	7.6	5400	16300	13500	0.63	0	0.0135	0.082	1.55	0.016	-0.64	1.68	1.68
ITF	0.38	4500	13500	11300	0.076	-0.12	14.59	1.005	-0.016	0.088	0.088	1.01	1.01
	2.9	0.15	3.7	0.39	0.46	0	14.59	0.05	14.5	38	60.8	60.8	60.8
	0.15	210	644	547	0	0.625	1.2	1.2	-0.8	1.6	2.7	2.7	2.7
Complex roots, ITF	3.7	644	2060	1700	-0.11	0	1.17	1.17	0.54	-0.37	0.23	1.38	1.38
	0.39	547	1700	1435	0.13	-0.24	0.3	0.3	-0.99	-0.15	0.56	1.18	1.18

sum of diagonal values of  $\|x_{ik}\|$  which were measured directly

527

$$(49) \quad \delta_{\text{absmax}}^2 \doteq \sum_i a_{ii}.$$

The validity of this approximation is based on the high ratio between  $x_{ii}$  and  $\lambda_{ii}$  values.

The matrices in table 3 illustrate the interesting fact that orthogonality of odd and even  $a_i$  coefficients, expressed by  $\lambda_{01} = \lambda_{12} = 0$ , does not mean that there is no influence of errors in odd coefficients settings to even coefficients settings found by minimization of  $\kappa$ ; on the contrary, from the second row of both  $\|x_{ik}\|$  matrices we find

$$(50) \quad \frac{\delta_2}{\delta_1} = \mu_{12} = \frac{x_{12}}{x_{11}} \doteq 3$$

that is, a 1% error in  $a_1$  setting causes the value  $a_2$  to be found with a 3% error.

This is caused by the interference of  $b_1$  which is orthogonal with no  $a_i$  coefficient. A change in  $a_1$  setting causes a shift in the position of  $b_1$  minimum, and the resulting change of  $b_1$  shifts the  $a_2$  minimum.

If the results in table 2 could perhaps appear yet acceptable for a practical application, this could hardly be said about the  $\delta_{\text{abs}}$  values in table 3.

Like in table 2, the ITF method yields here better results. The largest axis and its ratio to the shortest one is approximately three times less if ITF the method is used.

Nevertheless, the results for ITF are not acceptable for practical application.

Together with the spectral situation already discussed one further circumstance is also responsible for the poor results. In the transfer function (45), like in all transfer functions with a numerator there is more room for compensation of a change of one coefficient by changes of others. This compensation can, e.g., limit the influence of a shift of a pole to a short portion of the frequency characteristic, ranging from that pole to the next zero or pole.

But details of the frequency response characteristic which influence only a narrow frequency band will have a very slight effect on the whole spectral energy of the error signal  $\bar{A}$  if disturbing noise is present.

An error in identifying coefficients of a transfer function has to be judged not only by its total value but also by its components, that is, by its direction if it is regarded as a vector. The influence of errors in various coefficients can add or compensate in the control loop. Ideally, a change, which is irrelevant for the control loop, could be allowed to be less noticeable in the identification process. The errors for the transfer function (45) lie nearly always in the direction of the longest axis because the sensitivity in this direction, (that is the change in  $\kappa$  for a given error) compared with the most favourable direction, is 2650 times less for ITF and 28700 times less for DTF. The direction of the longest axis is nearly the same for both ITF and DTF and can be expressed approximately by the ratio

$$(51) \quad \delta_1 : \delta_2 : \delta_3 = 1 : 3 : 2.5.$$

Fig. 17 shows the asymptotic logarithmic frequency response characteristics of the transfer function (42) for nominal values (full line) and for  $\delta_T = 0.5$  in the longest axis direction, that is

$$(52) \quad \delta_1 = 0.124; \quad \delta_2 = 0.372; \quad \delta_3 = 0.31.$$

Fig. 17 proves that the changes of the individual coefficients compensate each other and the resulting effect on the frequency response is much less than that corresponding to an error of the same magnitude in any single coefficient. One may thus expect that also in a control loop the  $\delta_i$  changes will compensate to a certain extent. An exact estimation is, of course, not possible without some knowledge about the respective control loop.

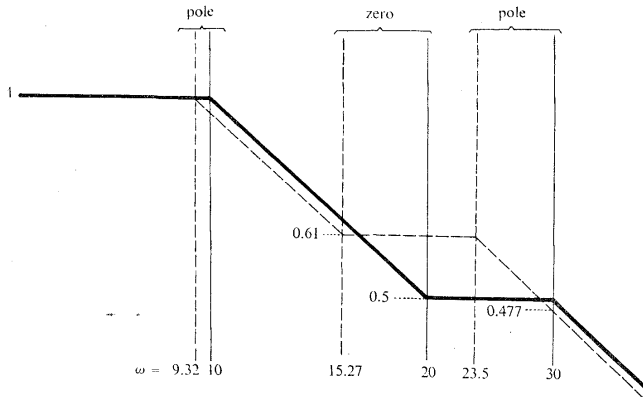


Fig. 17. Effect of total error  $\sigma_T = 0.5$  in long axis direction on frequency response.

#### CONCLUSIONS

Both studied methods yield possibilities for automation of the identification process from the standpoint of hypersurface  $\kappa = \text{const.}$  form simplicity.

The ITF method proved to be substantially better from the sensitivity standpoint if more than two parameters are to be determined.

The sensitivity of both methods decreases extremely rapidly if the number of unknown parameters is raised. The rate of this decrease in the experiments involved can be very roughly expressed by two orders of magnitude per one unknown parameter added (that is, one order of magnitude of error increase).

Thus, no simple straightforward method seems promising if more than three parameters are unknown, inspite of the favourable circumstance that errors which compensate from the identification method standpoint seem to compensate to a certain extent from the control loop design standpoint too.

The most natural way for improving the method sensitivity seems to be some filtering of the signals involved which would stress the frequencies lying in the band most influenced by the respective coefficient changes and suppressing those which do not.

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## Identifikace dynamických parametrů regulačních soustav pomocí nastavitelných modelů

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V ÚTIA ČSAV byla ve spolupráci s pracovníky IAT AV SSSR provedena s pomocí stroje MUSA-6 podrobná experimentální prověrka dvou metod, užívajících modelů pro identifikaci dynamických parametrů soustav na základě zpracování zaznamenaných vstupních a výstupních signálů stochastického charakteru.

Zejména byl podrobně prověřen vliv odchylek od správného nastavení modelů na hodnotu použitého integrálního kvadratického kritéria, tvar nadploch s konstantní hodnotou tohoto kritéria. Z výsledků jsou odvozovány závěry o možnostech identifikace dynamických parametrů za přítomnosti rušivých šumů a podrobněji osvětleny některé výhodné i limitující faktory v metodách zkoumaného druhu.

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